




TEST REPORT

KCTL KCTL Inc. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea TEL: 82-31-285-0894 FAX: 82-505-299-8311 www.kctl.co.kr	Report No.: KR20-SRF0263 Page (1) of (17)				
1. Client ◦ Name : Samsung Electronics Co., Ltd. ◦ Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea ◦ Date of Receipt : 2020-09-28 2. Use of Report : Class II Permissive change 3. Name of Product / Model : Mobile phone / SM-F415F/DS 4. Manufacturer / Country of Origin : Samsung Electronics Co., Ltd. / Vietnam 5. FCC ID : A3LSMM315F 6. Date of Test : 2020-10-06 to 2020-10-15 7. Location of Test : <input checked="" type="checkbox"/> Permanent Testing Lab <input type="checkbox"/> On Site Testing (Address: Address of testing location) 8. Test method used : FCC Part 15 Subpart C, 15.247 9. Test Result : Refer to the test result in the test report					
<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 15%; text-align: center; vertical-align: middle;">Affirmation</td> <td style="width: 40%; padding: 5px;"> Tested by Name : Kwonse Kim (Signature) </td> <td style="width: 45%; padding: 5px;"> Technical Manager Name : Seungyong Kim (Signature) </td> </tr> </table>			Affirmation	Tested by Name : Kwonse Kim (Signature)	Technical Manager Name : Seungyong Kim (Signature)
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2020-10-16					
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<p>KCTL KCTL Inc. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea TEL: 82-31-285-0894 FAX: 82-505-299-8311 www.kctl.co.kr</p>	<p>Report No.: KR20-SRF0263</p> <p>Page (2) of (17)</p>	
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REPORT REVISION HISTORY

Date	Revision	Page No
2020-10-16	Originally issued	-

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General remarks for test reports

Nothing significant to report.



CONTENTS

1.	General information	4
2.	Device information	4
2.1.	Accessory information	6
2.2.	Frequency/channel operations.....	6
3.	Summary of tests	7
4.	Measurement uncertainty	8
5	Test results	9
5.1.	Radiated spurious emissions & band edge.....	9
6.	Measurement equipment.....	17

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1. General information

Client : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Manufacturer : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Factory : Samsung Electronics Vietnam Thai Nguyen Co., Ltd
 Address : 506-723 16000 Yen Phong 1 Industrial Zone, Yen Trung Commu, Yen Phong District, Bac Ninh Province, Vietnam
 Factory : Samsung India Electronics PVT. Ltd
 Address : B-1, Sector-8 NOIDA Uttar Pradesh, India 201-305
 Factory : Samsung Electronics Co., Ltd.
 Address : 94-1, Imsu-dong, Gumi-si, Gyeongsangbuk-ro, 730-722, Republic of Korea
 Laboratory : KCTL Inc.
 Address : 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
 Accreditations : FCC Site Designation No: KR0040, FCC Site Registration No: 687132
 VCCI Registration No. : R-20080, G-20078, C-20059, T-20056
 Industry Canada Registration No. : 8035A
 KOLAS No.: KT231

2. Device information

Equipment under test : Mobile phone
 Model : SM-F415F/DS
 Modulation technique : Bluetooth(BDR/EDR)_GFSK, $\pi/4$ DQPSK, 8DPSK
 Bluetooth(BLE)_GFSK
 WIFI(802.11b/g/n20/n40/ac20/ac40/ac80)_DSSS, OFDM
 LTE_QPSK, 16QAM
 WCDMA_QPSK
 GSM_GMSK, 8-PSK
 Number of channels : Bluetooth(BDR/EDR)_79 ch / Bluetooth(BLE)_40 ch
 WIFI(802.11b/g/n20)_11 ch
 UNII-1 : 4 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
 UNII-2A : 4 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
 UNII-2C : 12 ch (20 MHz), 6 ch (40 MHz), 3 ch (80 MHz)
 UNII-3 : 5 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
 Power source : DC 3.85 V
 Antenna specification : LTE/GSM/WCDMA_LDS Antenna
 WIFI/Bluetooth(BDR/EDR/BLE)_LDS Antenna

Antenna gain	: WIFI/Bluetooth(BDR/EDR/BLE) : -3.4 dBi UNII-1 -5.9 dBi UNII-2A -6.3 dBi UNII-2C -5.3 dBi UNII-3 -6.6 dBi
Frequency range	: Bluetooth(BDR/EDR/BLE)_2 402 MHz ~ 2 480 MHz 2 412 MHz ~ 2 462 MHz (802.11b/g/n_HT20) UNII-1: 5 180 MHz ~ 5 240 MHz (802.11a/n_HT20/ac_VHT20) UNII-1: 5 190 MHz ~ 5 230 MHz (802.11n_HT40/ac_VHT40) UNII-1: 5 210 MHz (802.11ac_VHT80) UNII-2A: 5 260 MHz ~ 5 320 MHz (802.11a/n_HT20/ac_VHT20) UNII-2A: 5 270 MHz ~ 5 310 MHz (802.11n_HT40/ac_VHT40) UNII-2A: 5 290 MHz (802.11ac_VHT80) UNII-2C: 5 500 MHz ~ 5 720 MHz (802.11a/n_HT20/ac_VHT20) UNII-2C: 5 510 MHz ~ 5 710 MHz (802.11n_HT40/ac_VHT40) UNII-2C: 5 530 MHz ~ 5 690 MHz (802.11ac_VHT80) UNII-3: 5 745 MHz ~ 5 825 MHz (802.11a/n_HT20/ac_VHT20) UNII-3: 5 755 MHz ~ 5 795 MHz (802.11n_HT40/ac_VHT40) UNII-3: 5 775 MHz (802.11ac_VHT80) LTE Band 2_1 850.7 MHz ~ 1 909.3 MHz LTE Band 4_1 710.7 MHz ~ 1 754.3 MHz LTE Band 5_824.7 MHz ~ 848.3 MHz LTE Band 12_699.7 MHz ~ 715.3 MHz LTE Band 13_779.5 MHz ~ 784.5 MHz LTE Band 17_706.5 MHz ~ 713.5 MHz LTE Band 26_824.7 MHz ~ 848.3 MHz, 814.7 MHz ~ 823.3 MHz LTE Band 41_2 498.5 MHz ~ 2 687.5 MHz LTE Band 66_1 710.7 MHz ~ 1 779.3 MHz GSM 850_824.2 MHz ~ 848.8 MHz GSM 1900_1 850.2 MHz ~ 1 909.8 MHz WCDMA 850_826.4 MHz ~ 846.6 MHz WCDMA 1700_1 712.4 MHz ~ 1 752.6 MHz WCDMA 1900_1 852.4 MHz ~ 1 907.6 MHz
Software version	: M315F.001
Hardware version	: REV1.0
Test device serial No.	: Conducted(R38N101EBQY), Radiated(R38N8004GRZ)
Operation temperature	: -30 °C ~ 50 °C

2.1. Accessory information

Equipment	Manufacturer	Model	Serial No.	Power source
Travel Adapter	Samsung Electronics Co., Ltd.	EP-TA200	R37M4NR27T1SE3	AC 100-240V 50-60 Hz, 0.5A, 9.0V-1.67A, 5.0V-2.0A
Micro USB Data Cable	Samsung Electronics Co., Ltd.	-	-	-

2.2. Frequency/channel operations

This device contains the following capabilities:

WIFI (802.11a/b/g/n/ac), Bluetooth (BDR/EDR/BLE),

LTE Band 2, LTE Band 4, LTE Band 5, LTE Band 12, LTE Band 13, LTE Band 17, LTE Band 26,
LTE Band 41, LTE Band 66, WCDMA 850, WCDMA 1700, WCDMA 1900, GSM 850, GSM 1900

Ch.	Frequency (MHz)
00	2 402
.	.
39	2 441
.	.
78	2 480

Table 2.2.1. Bluetooth(BDR/EDR) mode

15.247 Requirements for Bluetooth transmitter:

- This Bluetooth module has been tested by a Bluetooth Qualification Lab, and we confirm the following:
 - 1) This system is hopping pseudo-randomly.
 - 2) Each frequency is used equally on the average by each transmitter.
 - 3) The receiver input bandwidths that match the hopping channel bandwidths of their corresponding transmitters
 - 4) The receiver shifts frequencies in synchronization with the transmitted signals.
- 15.247(g): The system, consisting of both the transmitter and the receiver, must be designed to comply with all of the regulations in this Section 15.247 should the transmitter be presented with a continuous data (or information) stream.
- 15.247(h): The coordination of frequency hopping systems in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.

3. Summary of tests

FCC Part section(s)	Parameter	Test condition	Test results
15.205(a), 15.209(a) 15.247(d)	Spurious emission	Radiated	Pass
	Band-edge, restricted band		Pass

Notes:

1. According to exploratory test no any obvious emission were detected from 9 kHz to 30 MHz. Although these tests were performed other than open field site, adequate comparison measurements were confirmed against 30 m open field site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.
2. The fundamental of the EUT was investigated in three orthogonal orientations X, Y and Z. It was determined that **X** orientation was worst-case orientation. Therefore, all final radiated testing was performed with the EUT in **X** orientation
3. The test procedure(s) in this report were performed in accordance as following.
 - ◆ ANSI C63.10-2013
 - ◆ KDB 558074 D01 v05r02
4. This is the C2PC test report to add a variant model, SM-F415F/DS as documented in the C2PC letter. Because the change does not affect RF characteristics, therefore, only radiated spurious emission test was done against the worst case from the main model, SM-M315F/DS, documented in the original filing and approved in 02/07/2020. All rest tests documented in original filing under model SM-M315F/DS remains representative of the variant model, SM-F415F/DS.

4. Measurement uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.10-2013.

All measurement uncertainty values are shown with a coverage factor of $k=2$ to indicated a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded uncertainty (\pm)	
Radiated spurious emissions	9 kHz ~ 30 MHz:	2.3 dB
	30 MHz ~ 300 MHz	5.4 dB
	300 MHz ~ 1 000 MHz	5.5 dB
	Above 1 GHz	6.7 dB

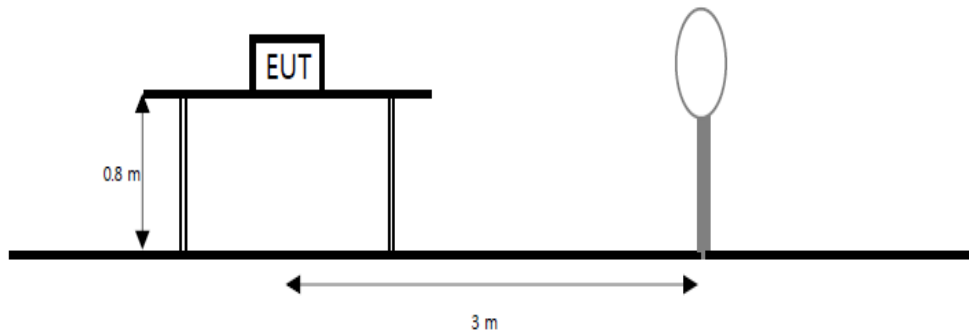
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5 Test results

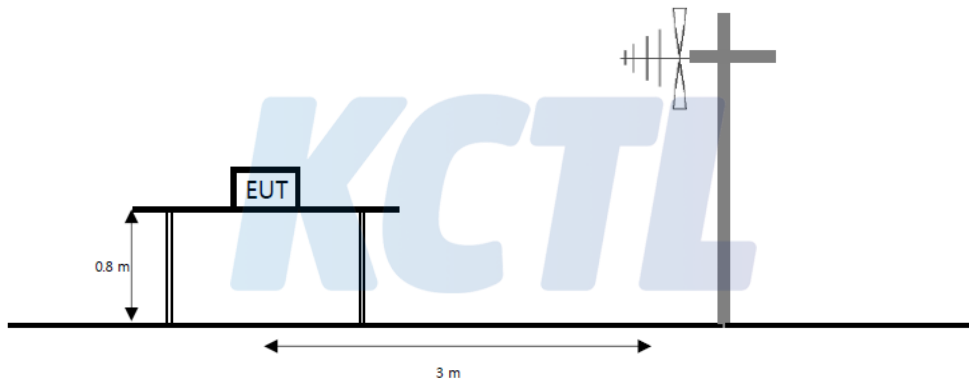
5.1. Radiated spurious emissions & band edge

Test setup

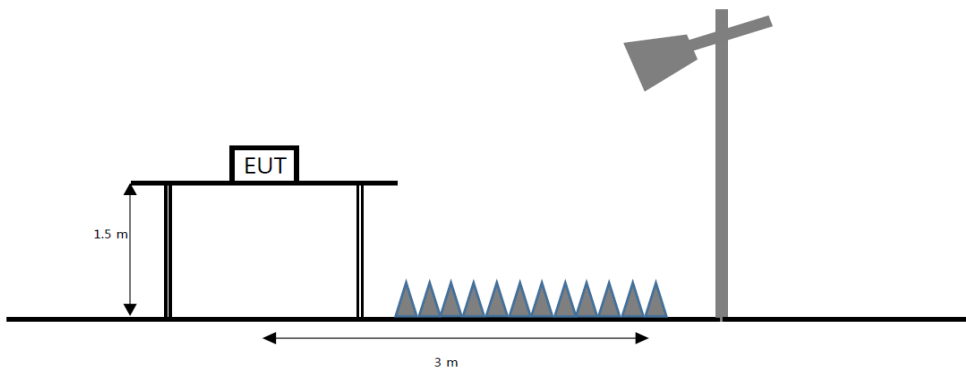
The diagram below shows the test setup that is utilized to make the measurements for emission from 9 kHz to 30 MHz Emissions



The diagram below shows the test setup that is utilized to make the measurements for emission from 30 MHz to 1 GHz emissions.



The diagram below shows the test setup that is utilized to make the measurements for emission from 1 GHz to the tenth harmonic of the highest fundamental frequency or to 40 GHz emissions, whichever is lower.



Limit

According to section 15.209(a), except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency (MHz)	Field strength ($\mu V/m$)	Measurement distance (m)
0.009 - 0.490	2 400/F(kHz)	300
0.490 - 1.705	24 000/F(kHz)	30
1.705 - 30	30	30
30 - 88	100**	3
88 - 216	150**	3
216 - 960	200**	3
Above 960	500	3

**Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54–72 MHz, 76–88 MHz, 174–216 MHz or 470–806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., Section 15.231 and 15.241.

According to section 15.205(a) and (b), only spurious emissions are permitted in any of the frequency bands listed below:

MHz	MHz	MHz	GHz
0.009 - 0.110	16.42 - 16.423	399.9 - 410	4.5 - 5.15
0.495 - 0.505	16.694 75 - 16.695 25	608 - 614	5.35 - 5.46
2.173 5 - 2.190 5	16.804 25 - 16.804 75	960 - 1 240	7.25 - 7.75
4.125 - 4.128	25.5 - 25.67	1 300 - 1 427	8.025 - 8.5
4.177 25 - 4.177 75	37.5 - 38.25	1 435 - 1 626.5	9.0 - 9.2
4.207 25 - 4.207 75	73 - 74.6	1 645.5 - 1 646.5	9.3 - 9.5
6.215 - 6.218	74.8 - 75.2	1 660 - 1 710	10.6 - 12.7
6.267 75 - 6.268 25	108 - 121.94	1 718.8 - 1 722.2	13.25 - 13.4
6.311 75 - 6.312 25	123 - 138	2 200 - 2 300	14.47 - 14.5
8.291 - 8.294	149.9 - 150.05	2 310 - 2 390	15.35 - 16.2
8.362 - 8.366	156.524 75 - 156.525	2 483.5 - 2 500	17.7 - 21.4
8.376 25 - 8.386 75	25	2 690 - 2 900	22.01 - 23.12
8.414 25 - 8.414 75	156.7 - 156.9	3 260 - 3 267	23.6 - 24.0
12.29 - 12.293	162.012 5 - 167.17	3 332 - 3 339	31.2 - 31.8
12.519 75 - 12.520 25	167.72 - 173.2	3 345.8 - 3 358	36.43 - 36.5
12.576 75 - 12.577 25	240 - 285	3 600 - 4 400	Above 38.6
13.36 - 13.41	322 - 335.4		

The field strength of emissions appearing within these frequency bands shall not exceed the limits shown in section 15.209. At frequencies equal to or less than 1 000 MHz, compliance with the limits in section 15.209 shall be demonstrated using measurement instrumentation employing a CISPR quasi-peak detector. Above 1 000 MHz, compliance with the emission limits in section 15.209 shall be demonstrated based on the average value of the measured emissions. The provisions in section 15.35 apply to these measurements.

Test procedure

ANSI C63.10-2013

Test settings**Peak field strength measurements**

1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
2. RBW = as specified in table
3. VBW \geq (3 \times RBW)
4. Detector = peak
5. Sweep time = auto
6. Trace mode = max hold
7. Allow sweeps to continue until the trace stabilizes

Table. RBW as a function of frequency

Frequency	RBW
9 kHz to 150 kHz	200 Hz to 300 Hz
0.15 MHz to 30 MHz	9 kHz to 10 kHz
30 MHz to 1 000 MHz	100 kHz to 120 kHz
> 1 000 MHz	1 MHz

Average field strength measurements

1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
2. RBW = 1 MHz
3. VBW = $1/T \geq 1$ Hz
4. Averaging type was set to RMS to ensure that video filtering was applied in the power domain
5. Detector = peak
6. Sweep time = auto
7. Trace mode = max hold
8. Trace was allowed to run for at least 50 times(1/duty cycle) traces

Notes:

1. $f < 30$ MHz, extrapolation factor of 40 dB/decade of distance. $F_d = 40\log(D_m/D_s)$
 $f \geq 30$ MHz, extrapolation factor of 20 dB/decade of distance. $F_d = 20\log(D_m/D_s)$
 Where:
 F_d = Distance factor in dB
 D_m = Measurement distance in meters
 D_s = Specification distance in meters
2. Factors(dB) = Antenna factor(dB/m) + Cable loss(dB) + or Amp. gain(dB) + or F_d (dB)
3. The worst-case emissions are reported however emissions whose levels were not within 20 dB of respective limits were not reported.
4. Average test would be performed if the peak result were greater than the average limit.
5. ¹⁾ means restricted band.

Duty cycle correction factor calculation:

According to 7.5 Procedure for determining the average value of pulsed emissions

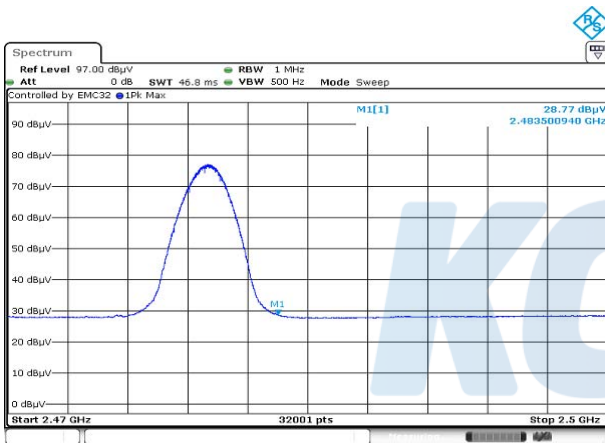
Duty Cycle Correction Factor Calculation

- Worst case : AFH mode
- Channel hop rate = 800 hops/second
- Hopping rate for DH5 mode = 800 hops/second / 5 (6 slots for DH5) = 133.33 hops/second
- Time per channel hop = $1 / 133.33 \text{ hops/second} = 7.50 \text{ ms}$
- Time to cycle through all channels = $7.50 \times 20 \text{ channels(AFH mode)} = 150 \text{ ms}$
- Number of times transmitter hits on one channel = $100 \text{ ms} / \text{Time to cycle through all channels (ms)}$
 $= 100 \text{ ms} / 150 \text{ ms} = 1 \text{ time}$
- Worst case Dwell time = 7.5 ms
- Duty Cycle Correction Factor = $20\log(7.5 \text{ ms}/100 \text{ ms}) = -22.5 \text{ dB}$

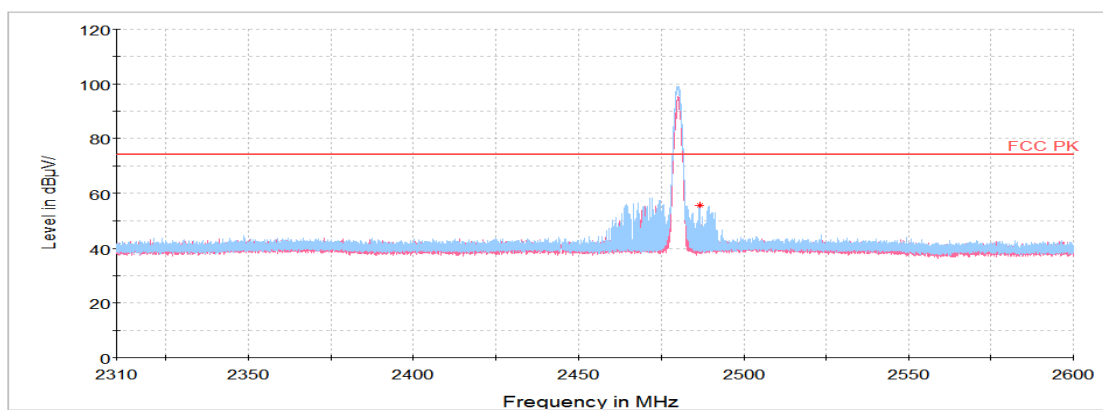
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Test results (Above 1 000 MHz)**GFSK / Band-edge****High Channel**

Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μ V))	(dB)	(dB)	(dB)	(dB(μ V/m))	(dB(μ V/m))	(dB)
Peak data								
2 483.50 ¹⁾	H	52.78	32.07	-29.21	-	55.64	74.00	18.36
Average Data								
2 483.50 ¹⁾	H	28.77	32.07	-29.21	-	31.63	54.00	22.37

Average data

Blank

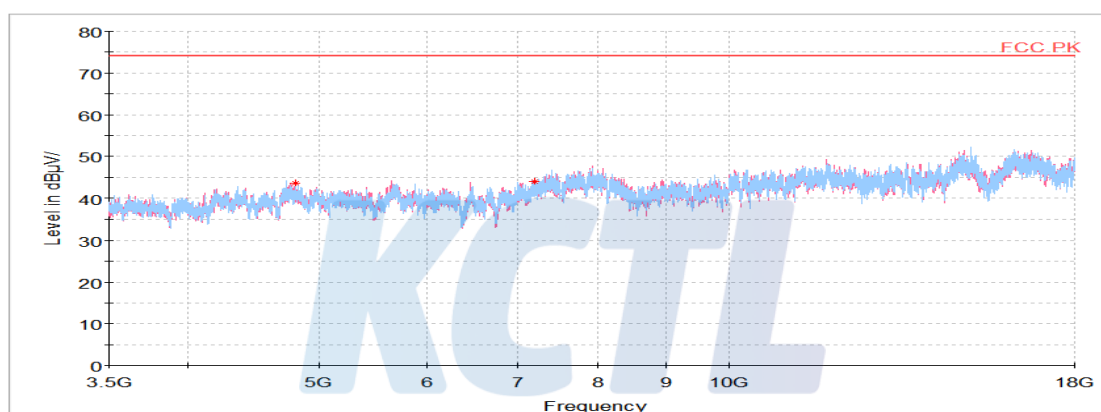
Horizontal/Vertical for Band-edge

GFSK / Harmonic

Low Channel

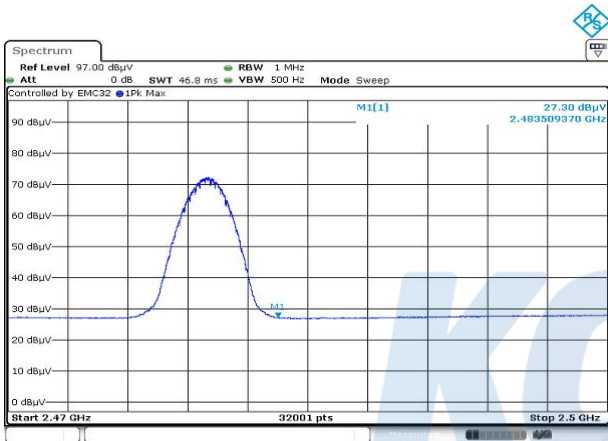
Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μV))	(dB)	(dB)	(dB)	(dB(μV/m))	(dB(μV/m))	(dB)
Peak data								
4 803.19 ¹⁾	H	62.64	33.92	-52.99	-	43.57	74.00	30.43
7 204.30 ¹⁾	H	61.64	35.40	-53.09	-	43.95	74.00	30.05
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

Horizontal/Vertical for 3.5 GHz ~ 18 GHz

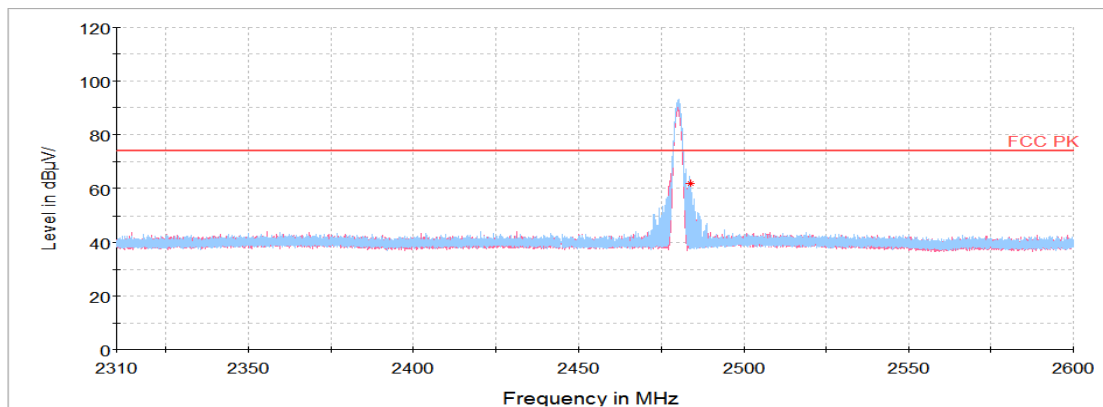


8DPSK / Band-edge**High Channel**

Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μ V))	(dB)	(dB)	(dB)	(dB(μ V/m))	(dB(μ V/m))	(dB)
Peak data								
2 483.51 ¹⁾	H	58.79	32.07	-29.21	-	61.65	74.00	12.35
Average Data								
2 483.51 ¹⁾	H	27.30	32.07	-29.21	-	30.16	54.00	23.84

Average data

Blank

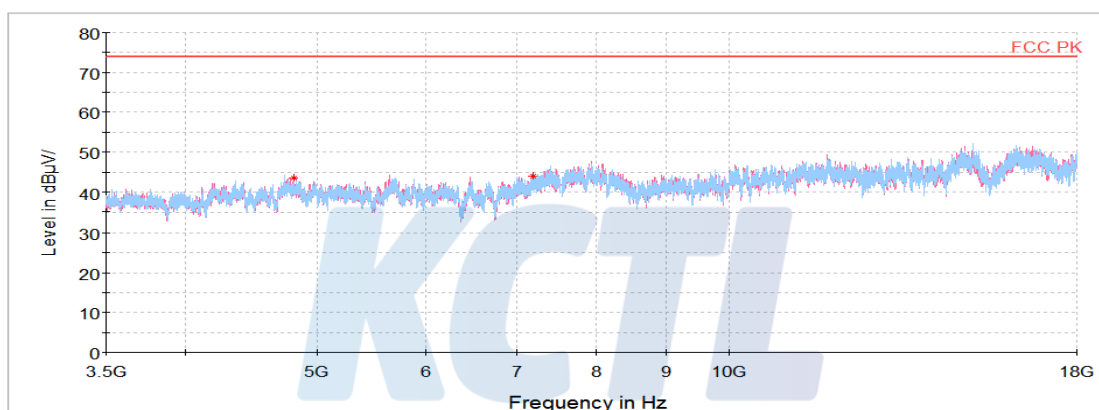
Horizontal/Vertical for Band-edge

8DPSK / Harmonic

Low Channel

Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μV))	(dB)	(dB)	(dB)	(dB(μV/m))	(dB(μV/m))	(dB)
Peak data								
4 819.05 ¹⁾	H	62.10	33.93	-53.44	-	42.59	74.00	31.41
7 210.64 ¹⁾	V	61.82	35.40	-53.07	-	44.15	74.00	29.85
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

Horizontal/Vertical for 3.5 GHz ~ 18 GHz



6. Measurement equipment

Equipment Name	Manufacturer	Model No.	Serial No.	Next Cal. Date
Spectrum Analyzer	R&S	FSV30	100806	21.07.29
Spectrum Analyzer	R&S	FSV40	100989	21.01.03
Attenuator	Weinschel ENGINEERING	56-10	51395	21.01.22
Signal Generator	R&S	SMB100A	176206	21.01.21
Vector Signal Generator	R&S	SMBV100A	257566	21.07.13
Signal Generator	R&S	SMR40	100007	21.04.08
Bluetooth Tester	TESCOM	TC-3000C	3000C000270	21.07.28
Highpass Filter	WT	WT-A1698-HS	WT160411001	21.05.11
Horn antenna	ETS.lindgren	3117	155787	20.10.24
Horn antenna	ETS.lindgren	3116	00086632	21.02.17
Attenuator	API Inmet	40AH2W-10	12	21.05.12
Broadband PreAmplifier	SCHWARZBECK	BBV9718	216	21.07.28
AMPLIFIER	L-3 Narda-MITEQ	AMF-7D-01001800 -22-10P	2031196	21.02.12
AMPLIFIER	L-3 Narda-MITEQ	JS44-18004000-33-8P	2000996	21.01.22
Antenna Mast	Innco Systems	MA4000-EP	303	-
Turn Table	Innco Systems	DT2000	79	-

End of test report